

**Search Notes**

Application/Control No.

10/784,594

Examiner

Yonel Beaulieu

Applicant(s)/Patent under  
Reexamination

OCKERSE ET AL.

Art Unit

3661

**SEARCHED**

Class	Subclass	Date	Examiner
701	224	12/20/2005	YB
702	92-93	12/20/2005	YB
434	1	12/22/2005	YB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST	12/22/2005	YB